

BUK6510-75C

N-channel TrenchMOS FET

Rev. 02 — 13 December 2010

Product data sheet

1. Product profile

1.1 General description

Standard and logic level gate drive N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using advanced TrenchMOS technology. This product has been designed and qualified to the appropriate AEC Q101 standard for use in high performance automotive applications.

1.2 Features and benefits

- AEC Q101 compliant
- Suitable for intermediate level gate drive sources
- Suitable for thermally demanding environments due to 175 °C rating

1.3 Applications

- 12 V Automotive systems
- Electric and electro-hydraulic power steering
- Motors, lamps and solenoid control management
- Start-Stop micro-hybrid applications
- Transmission control
- Ultra high performance power switching

1.4 Quick reference data

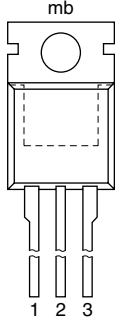
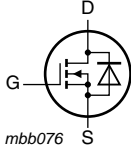
Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|------------------------|--|---|-----|------|------|------|
| V _{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | - | - | 75 | V |
| I _D | drain current | V _{GS} = 10 V; T _{mb} = 25 °C; see Figure 1 | - | - | 77 | A |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see Figure 2 | - | - | 158 | W |
| Static characteristics | | | | | | |
| R _{DSon} | drain-source on-state resistance | V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; see Figure 13 | - | 8.9 | 10.4 | mΩ |
| | | V _{GS} = 5 V; I _D = 15 A; T _j = 25 °C; see Figure 14 | - | 11.1 | 13 | mΩ |
| Avalanche ruggedness | | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | I _D = 77 A; V _{sup} ≤ 75 V; R _{GS} = 50 Ω; V _{GS} = 10 V; T _{i(init)} = 25 °C; unclamped | - | - | 122 | mJ |



2. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-----------------------------------|---|---|
| 1 | G | gate |  |  |
| 2 | D | drain | | |
| 3 | S | source | | |
| mb | D | mounting base; connected to drain | | |

SOT78A (TO-220AB)

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|-------------|----------|--|---------|
| | Name | Description | Version |
| BUK6510-75C | TO-220AB | plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB | SOT78A |

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------------------------|--|--|-----|-----|------|
| V_{DS} | drain-source voltage | $T_j \geq 25\text{ °C}; T_j \leq 175\text{ °C}$ | - | 75 | V |
| V_{GS} | gate-source voltage | DC [1] | -16 | 16 | V |
| | | Pulsed [2] | -20 | 20 | V |
| I_D | drain current | $T_{mb} = 25\text{ °C}; V_{GS} = 10\text{ V};$ see Figure 1 | - | 77 | A |
| | | $T_{mb} = 100\text{ °C}; V_{GS} = 10\text{ V};$ see Figure 1 | - | 54 | A |
| I_{DM} | peak drain current | $T_{mb} = 25\text{ °C};$ pulsed; $t_p \leq 10\text{ }\mu\text{s};$ see Figure 3 | - | 305 | A |
| P_{tot} | total power dissipation | $T_{mb} = 25\text{ °C};$ see Figure 2 | - | 158 | W |
| T_{stg} | storage temperature | | -55 | 175 | °C |
| T_j | junction temperature | | -55 | 175 | °C |
| Source-drain diode | | | | | |
| I_S | source current | $T_{mb} = 25\text{ °C}$ | - | 77 | A |
| I_{SM} | peak source current | pulsed; $t_p \leq 10\text{ }\mu\text{s}; T_{mb} = 25\text{ °C}$ | - | 305 | A |
| Avalanche ruggedness | | | | | |
| $E_{DS(AL)S}$ | non-repetitive drain-source avalanche energy | $I_D = 77\text{ A}; V_{sup} \leq 75\text{ V}; R_{GS} = 50\text{ }\Omega;$ $V_{GS} = 10\text{ V}; T_{j(init)} = 25\text{ °C};$ unclamped | - | 122 | mJ |
| $E_{DS(AL)R}$ | repetitive drain-source avalanche energy | [3][4][5] | - | - | J |

[1] -16V accumulated duration not to exceed 168 hrs.

[2] Accumulated pulse duration not to exceed 5mins.

[3] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

[4] Repetitive avalanche rating limited by an average junction temperature of 170 °C.

[5] Refer to application note AN10273 for further information.

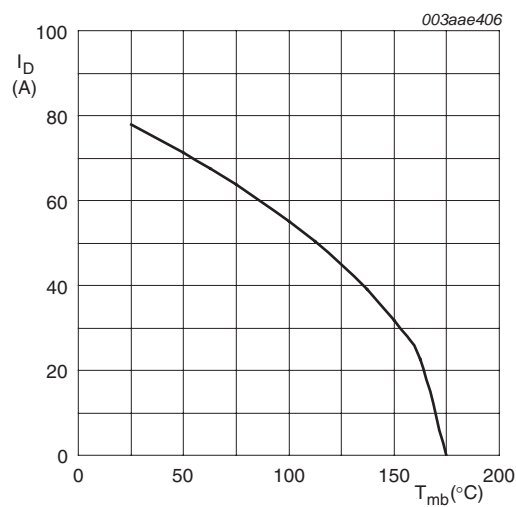
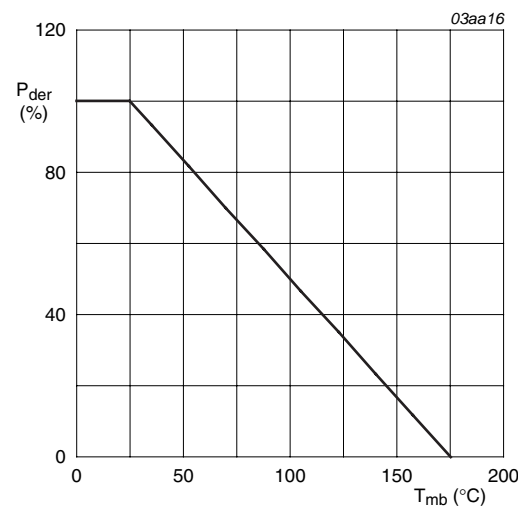


Fig 1. Continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature

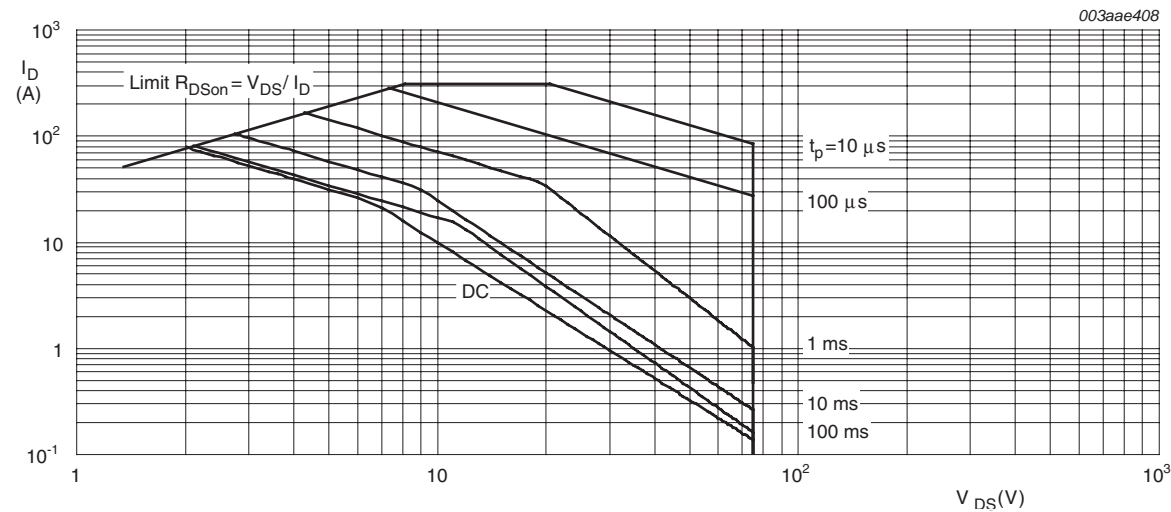


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------------|---|------------------------------|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | see Figure 4 | - | - | 0.95 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | vertical in free air | - | 60 | - | K/W |

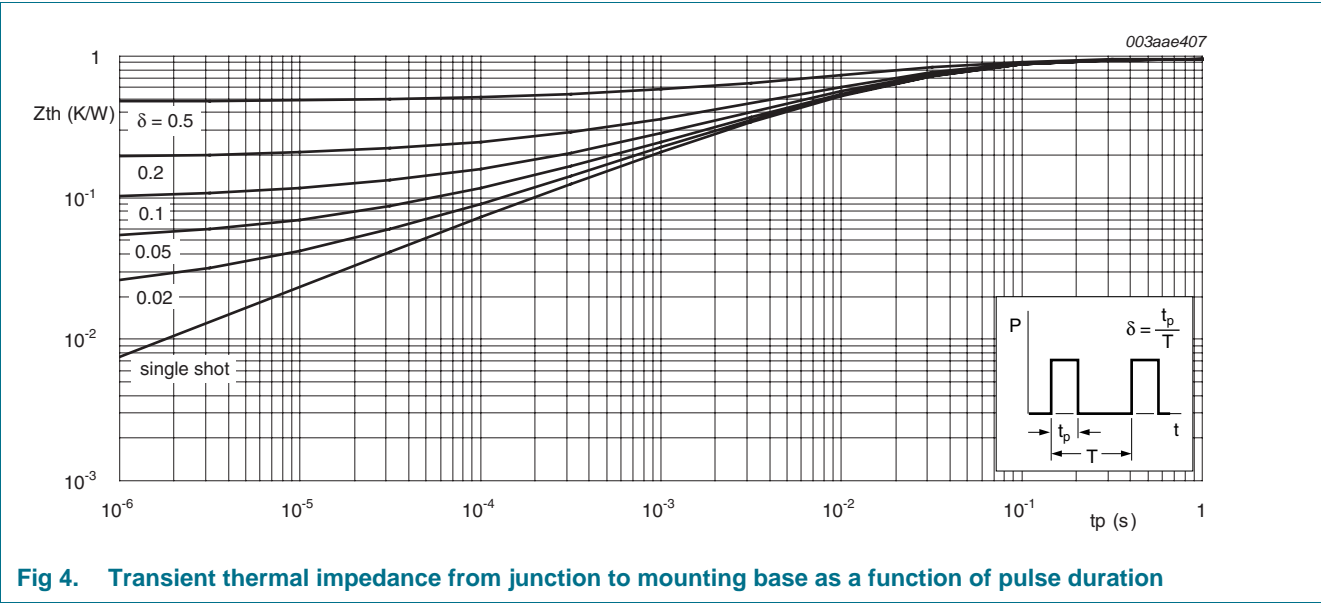


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-------------------------|----------------------------------|---|-----|------|------|------------|
| Static characteristics | | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $I_D = 250\ \mu A$; $V_{GS} = 0\ V$; $T_j = 25\ ^\circ C$ | 75 | - | - | V |
| | | $I_D = 250\ \mu A$; $V_{GS} = 0\ V$; $T_j = -55\ ^\circ C$ | 68 | - | - | V |
| | | | 27 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D = 1\ mA$; $V_{DS} = V_{GS}$; $T_j = 25\ ^\circ C$; see Figure 9 ; see Figure 10 | 1.8 | 2.3 | 2.8 | V |
| | | $I_D = 1\ mA$; $V_{DS} = V_{GS}$; $T_j = 175\ ^\circ C$; see Figure 11 | 0.5 | - | - | V |
| | | $I_D = 1\ mA$; $V_{DS} = V_{GS}$; $T_j = -55\ ^\circ C$; see Figure 9 | - | - | 3.3 | V |
| | | $I_D = 1\ mA$; $V_{DS} = V_{GS}$; $T_j = 25\ ^\circ C$; see Figure 11 ; see Figure 12 | 1.1 | 1.5 | 2 | V |
| | | $I_D = 1\ mA$; $V_{DS} = V_{GS}$; $T_j = 175\ ^\circ C$; see Figure 9 | 0.8 | - | - | V |
| I_{DSS} | drain leakage current | $V_{DS} = 75\ V$; $V_{GS} = 0\ V$; $T_j = 175\ ^\circ C$ | - | - | 500 | μA |
| | | $V_{DS} = 75\ V$; $V_{GS} = 0\ V$; $T_j = 25\ ^\circ C$ | - | 0.02 | 1 | μA |
| | | $V_{DS} = 30\ V$; $V_{GS} = 0\ V$; $T_j = 175\ ^\circ C$ | - | - | 500 | μA |
| I_{GSS} | gate leakage current | $V_{GS} = 20\ V$; $V_{DS} = 0\ V$; $T_j = 25\ ^\circ C$ | - | 2 | 100 | nA |
| | | $V_{GS} = -20\ V$; $V_{DS} = 0\ V$; $T_j = 25\ ^\circ C$ | - | 2 | 100 | nA |
| | | $V_{GS} = -15\ V$; $V_{DS} = 0\ V$; $T_j = 25\ ^\circ C$ | - | 2 | 100 | nA |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 10\ V$; $I_D = 25\ A$; $T_j = 25\ ^\circ C$; see Figure 13 | - | 8.9 | 10.4 | m Ω |
| | | $V_{GS} = 5\ V$; $I_D = 15\ A$; $T_j = 25\ ^\circ C$; see Figure 14 | - | 11.1 | 13 | m Ω |
| | | $V_{GS} = 4.5\ V$; $I_D = 15\ A$; $T_j = 25\ ^\circ C$; see Figure 14 | - | 11.4 | 12 | m Ω |
| | | $V_{GS} = 4.5\ V$; $I_D = 25\ A$; $T_j = 25\ ^\circ C$; see Figure 13 | - | 10.7 | 13 | m Ω |
| | | $V_{GS} = 10\ V$; $I_D = 15\ A$; $T_j = 25\ ^\circ C$; see Figure 14 | - | 10 | 11.7 | m Ω |
| | | $V_{GS} = 5\ V$; $I_D = 25\ A$; $T_j = 25\ ^\circ C$; see Figure 13 | - | 10.1 | 12.4 | m Ω |
| | | $V_{GS} = 10\ V$; $I_D = 25\ A$; $T_j = 175\ ^\circ C$; see Figure 15 ; see Figure 13 | - | - | 27 | m Ω |
| Dynamic characteristics | | | | | | |
| $Q_{G(tot)}$ | total gate charge | $I_D = 25\ A$; $V_{DS} = 60\ V$; $V_{GS} = 5\ V$; see Figure 16 ; see Figure 17 | - | 52 | - | nC |
| | | $I_D = 45\ A$; $V_{DS} = 15\ V$; $V_{GS} = 4.5\ V$; $T_j = 25\ ^\circ C$; see Figure 18 ; see Figure 17 | - | 5.9 | - | C |
| | | $I_D = 25\ A$; $V_{DS} = 60\ V$; $V_{GS} = 10\ V$; see Figure 17 ; see Figure 16 | - | 81 | - | nC |

Table 6. Characteristics ...continued

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---------------------------|------------------------------|---|-----|------|------|------|
| Q_{GS} | gate-source charge | $I_D = 25\text{ A}$; $V_{DS} = 60\text{ V}$; $V_{GS} = 10\text{ V}$; see Figure 16 ; see Figure 17 | - | 11 | - | nC |
| Q_{GD} | gate-drain charge | | - | 30 | - | nC |
| C_{iss} | input capacitance | $V_{GS} = 0\text{ V}$; $V_{DS} = 25\text{ V}$; $f = 1\text{ MHz}$; $T_j = 25\text{ }^\circ\text{C}$; see Figure 20 | - | 3938 | 5251 | pF |
| C_{oss} | output capacitance | | - | 310 | 372 | pF |
| C_{rss} | reverse transfer capacitance | | - | 206 | 282 | pF |
| $t_{d(on)}$ | turn-on delay time | $V_{DS} = 55\text{ V}$; $R_L = 2.2\text{ }\Omega$; $V_{GS} = 10\text{ V}$; $R_{G(ext)} = 10\text{ }\Omega$ | - | 18 | - | ns |
| t_r | rise time | | - | 40 | - | ns |
| $t_{d(off)}$ | turn-off delay time | | - | 165 | - | ns |
| t_f | fall time | | - | 80 | - | ns |
| L_D | internal drain inductance | from drain lead 6 mm from package to centre of die ; $T_j = 25\text{ }^\circ\text{C}$ | - | 4.5 | - | nH |
| L_S | internal source inductance | from source lead to source bond pad ; $T_j = 25\text{ }^\circ\text{C}$ | - | 7.5 | - | nH |
| Source-drain diode | | | | | | |
| V_{SD} | source-drain voltage | $I_S = 25\text{ A}$; $V_{GS} = 0\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$; see Figure 19 | - | 0.8 | 1.2 | V |
| t_{rr} | reverse recovery time | $I_S = 20\text{ A}$; $di_S/dt = -100\text{ A}/\mu\text{s}$; $V_{GS} = 0\text{ V}$; $V_{DS} = 25\text{ V}$ | - | 50.5 | - | ns |
| Q_r | recovered charge | | - | 105 | - | nC |

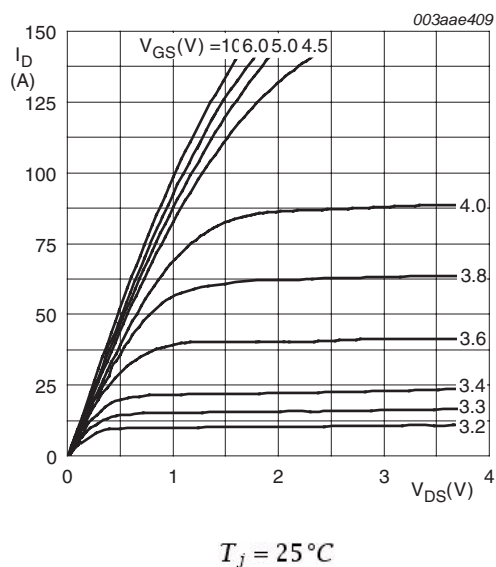


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

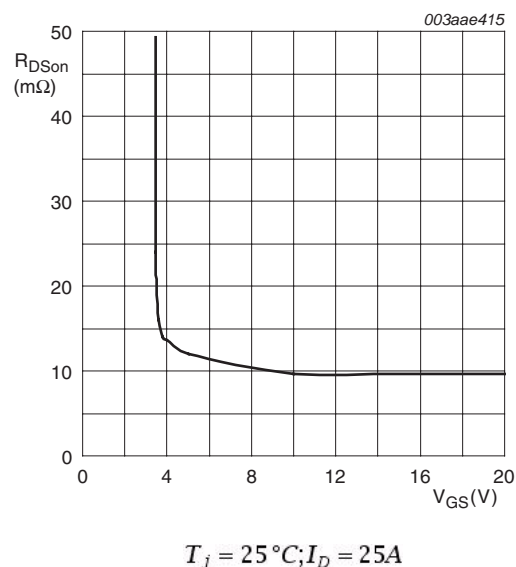
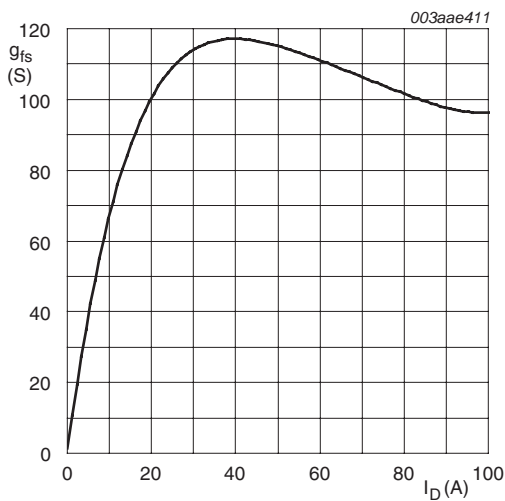
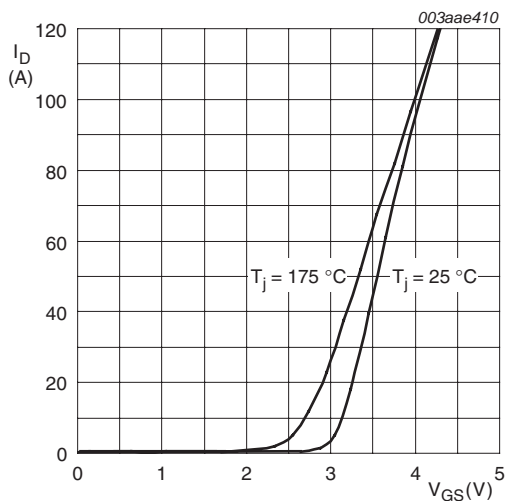


Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values.



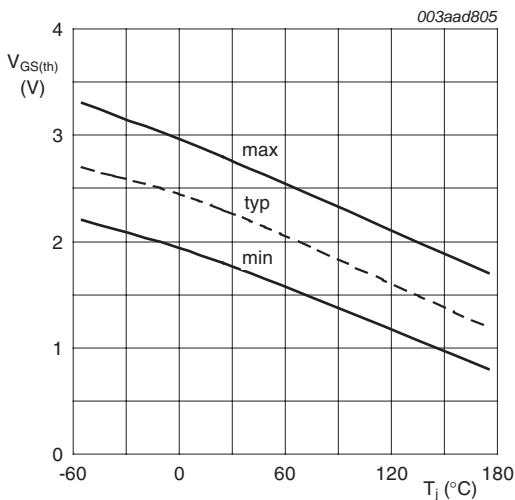
$T_j = 25\text{ }^{\circ}\text{C}; V_{DS} = 25\text{ V}$

Fig 7. Forward transconductance as a function of drain current; typical values



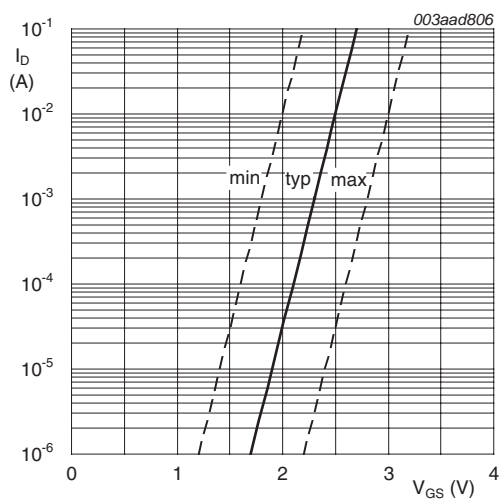
$V_{DS} > I_D \times R_{DS(on)}$

Fig 8. Transfer characteristics: drain current as a function of gate-source voltage; typical values



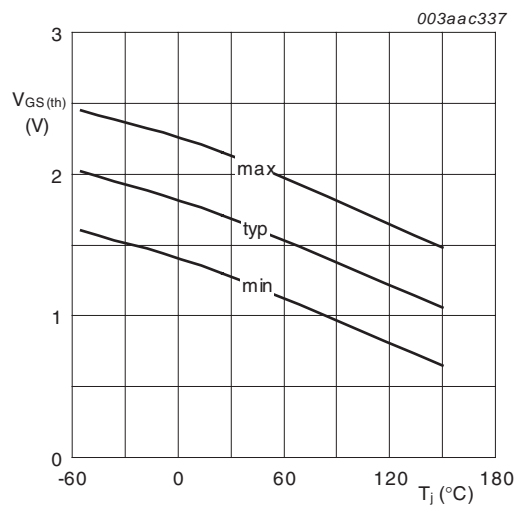
$I_D = 1\text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



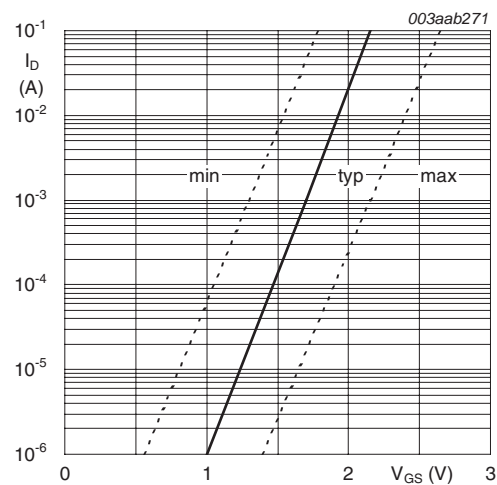
$T_j = 25\text{ }^{\circ}\text{C}; V_{DS} = 5\text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



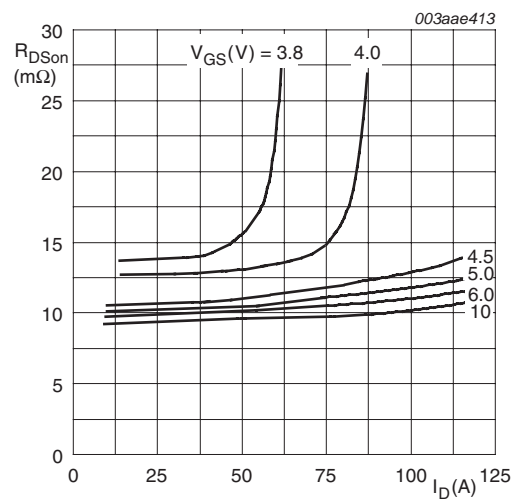
$I_D = 1\text{mA}; V_{DS} = V_{GS}$

Fig 11. Gate-source threshold voltage as a function of junction temperature



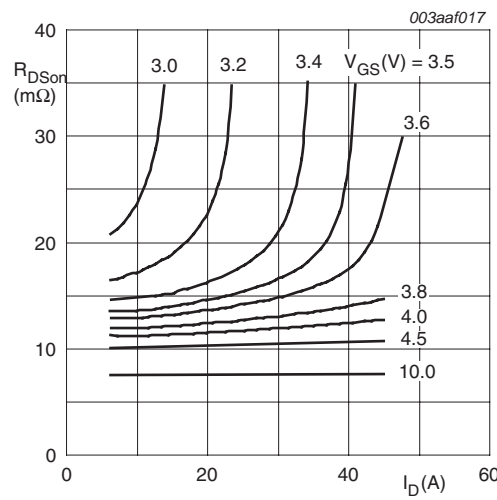
$T_j = 25\text{ }^\circ\text{C}; V_{DS} = 5\text{V}$

Fig 12. Sub-threshold drain current as a function of gate-source voltage



$T_j = 25\text{ }^\circ\text{C}$

Fig 13. Drain-source on-state resistance as a function of drain current; typical values



$T_j = 25\text{ }^\circ\text{C}$

Fig 14. Drain-source on-state resistance as a function of drain current; typical values

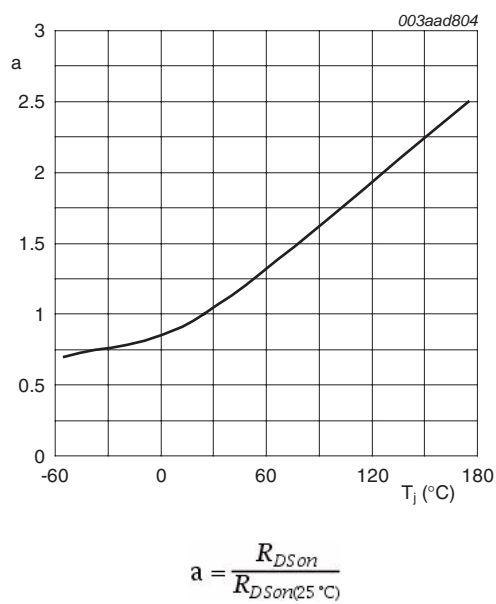


Fig 15. Normalized drain-source on-state resistance factor as a function of junction temperature

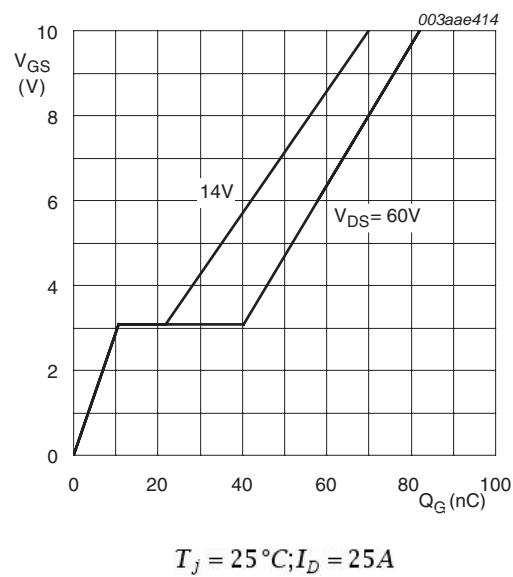


Fig 16. Gate-source voltage as a function of gate charge; typical values

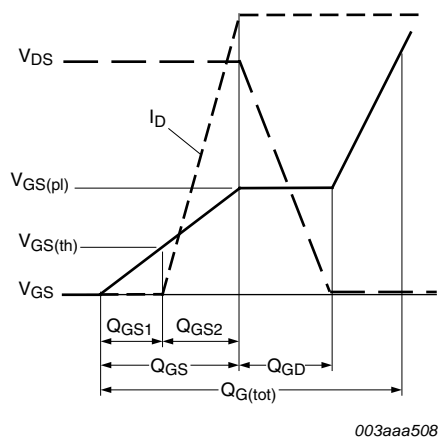


Fig 17. Gate charge waveform definitions

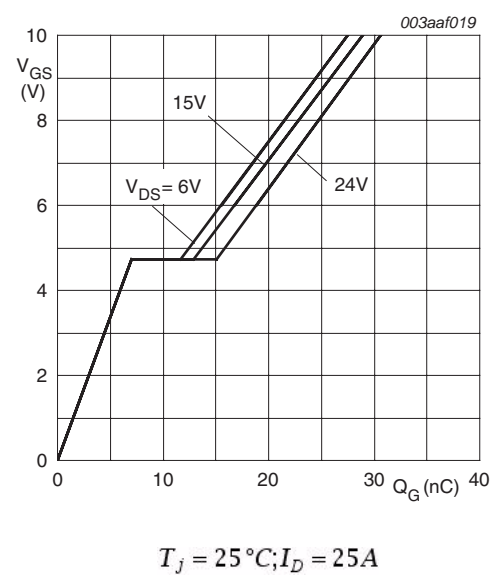


Fig 18. Gate-source voltage as a function of gate charge; typical values

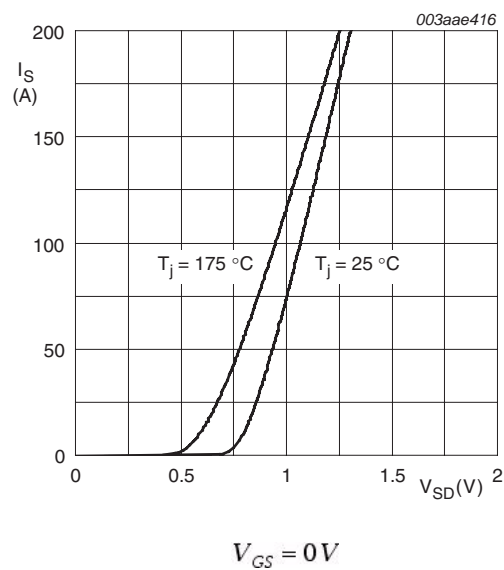


Fig 19. Source current as a function of source-drain voltage; typical values

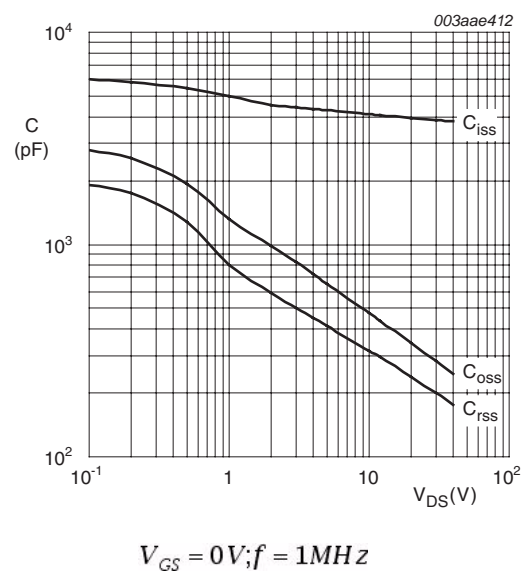


Fig 20. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78A

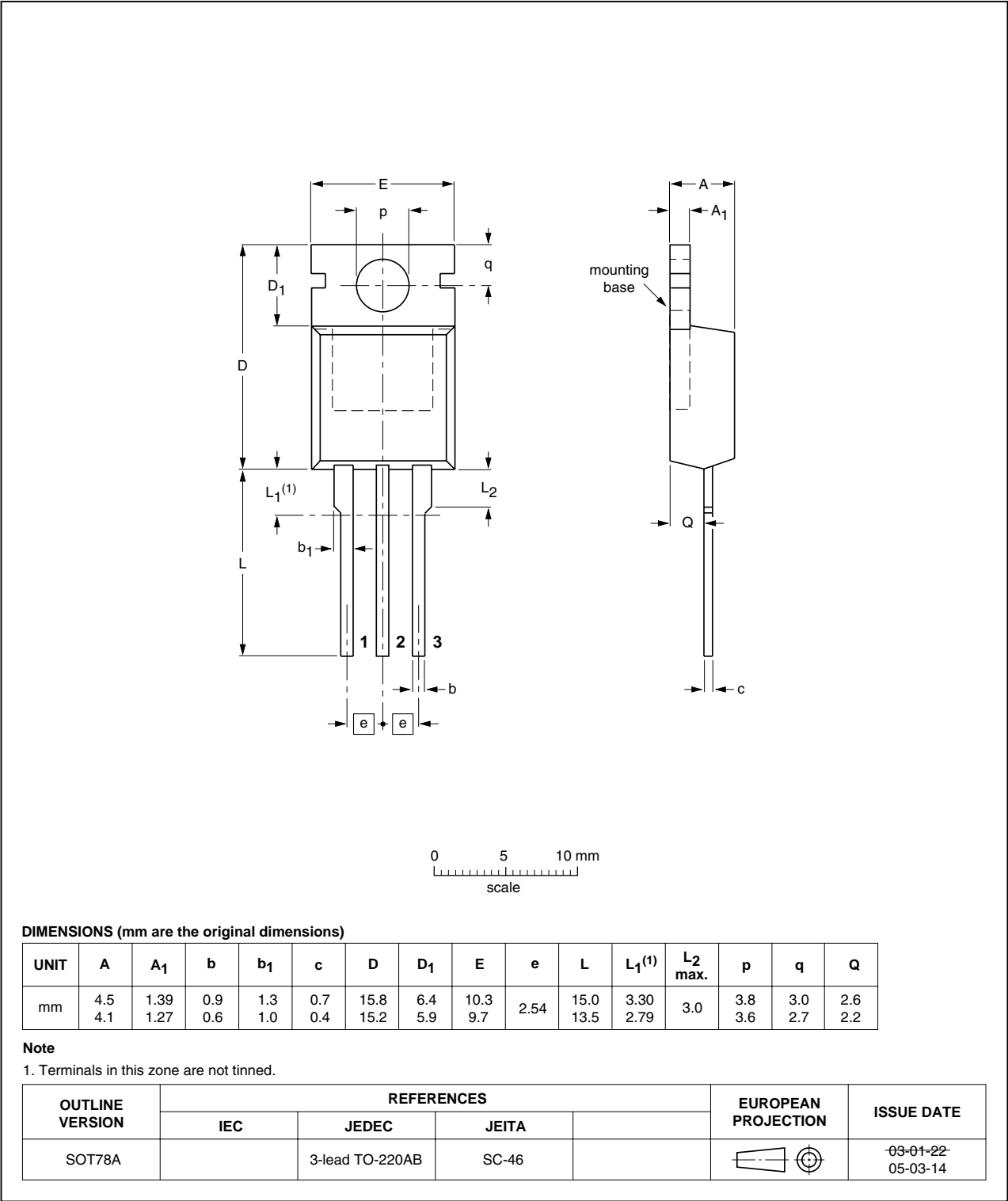


Fig 21. Package outline SOT78A (TO-220AB)

8. Revision history

Table 7. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|-----------------|---|----------------------|---------------|-----------------|
| BUK6510-75C v.2 | 20101213 | Product data sheet | - | BUK6510-75C v.1 |
| Modifications: | <ul style="list-style-type: none">• Status changed from objective to product.• Various changes to content. | | | |
| BUK6510-75C v.1 | 20100701 | Objective data sheet | - | - |

9. Legal information

9.1 Data sheet status

| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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For sales office addresses, please send an email to: salesaddresses@nxp.com

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For more information, please visit: <http://www.nxp.com>

For sales office addresses, please send an email to: salesaddresses@nxp.com

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